

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/722,906	HALLEE ET AL.	
Examiner	Art Unit	1
David T. Fidei	3728	

SEARCHED						
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Class	Subclass	Date	Examiner			
206	349 372 373 379	6/26/2006	DTF			
211	69 70.6	6/26/2006	DTF			
Above	Updated	11/14/2006	DTF			
Above	Updated	1/24/2007	DTF			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	search - see ce printout	1/24/2007	DTF	

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